

FORM 1449-1 P U.S. PATENT AND TRADEMARK OFFICE MY 30 2003 INFORMATION DISCLOSURE STATEMENT IN AN APPLICATION (Use several sheets if necessary)			Docket Number: 9997.69 US01	Application Number: 10/613,260
			Applicant: MANHAEVE et al.	
			Filing Date: 3 July 2003	Group Art Unit: 2858-2829

U.S. PATENT DOCUMENTS						
EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>PM</i>	5 818 268	6 Oct. 1998	KIM et al.	████████	████████	
	6 414 511 B1	2 July 2002	JANSSEN et al.	████████	████████	
	5 914 615	22 June 1999	CHESS	████████	████████	
<i>PM</i>	5 483 170	9 Jan. 1996	BEASLEY et al.	████████	████████	

FOREIGN PATENT DOCUMENTS						
	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
						YES
<i>PM</i>	EP 0 811 850 ✓	10 Dec. 1997	EPO	████████	████████	
	EP 0 386 804 ✓	12 Sept. 1990	EPO	████████	████████	
	EP 0 672 911 ✓	20 Sept. 1995	EPO	████████	████████	
	WO 98/15844 ✓	16 April 1998	WIPO	████████	████████	
<i>PM</i>	EP 1 107 013 ✓	13 June 2001	EPO	████████	████████	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)						
<i>PM</i>	✓	STRAKA et al. "A fully digital controlled off-chip I_{DDQ} measurement unit". Automation and Test in Europe, 1998. Proceedings Paris, France, Feb. 1998, Los Alamitos, CA, IEEE Comput. Soc, US, pp. 495-500 (23 Feb. 1998).				
	✓	SU et al. "Transient power supply current monitoring-a new test method for CMOS VLSI circuits". Journal of Electronic Testing: Theory and Applications, Vol. 6, No. 1, pp. 23-43 (1995).				
	✓	EICHENBERGER et al. "On Charge Injection in Analog MOS Switches and Dummy Switch Compensation Techniques". IEEE Transactions on Circuits and Systems, Vol. 37, No. 2, pp. 256-264 (Feb. 1990).				
<i>PM</i>	✓	EICHENBERGER et al. "Dummy Transistor Compensation of Analog MOS Switches". IEEE Journal of Solid-State Circuits, Vol. 24, No. 4, pp. 1143-1146 (August 1989).				

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PATENT TRADEMARK OFFICE

EXAMINER <i>-Pm</i>	DATE CONSIDERED <i>12/06/04</i>
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form for next communication to the Applicant.	